

**MOSFET Silicon N-Channel MOS****1. Applications**

Synchronous rectification in SMPS,  
Hard switching and High speed circuit  
DC/DC in telecoms and industrial

**2. Features**

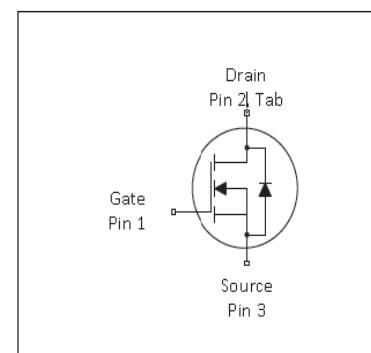
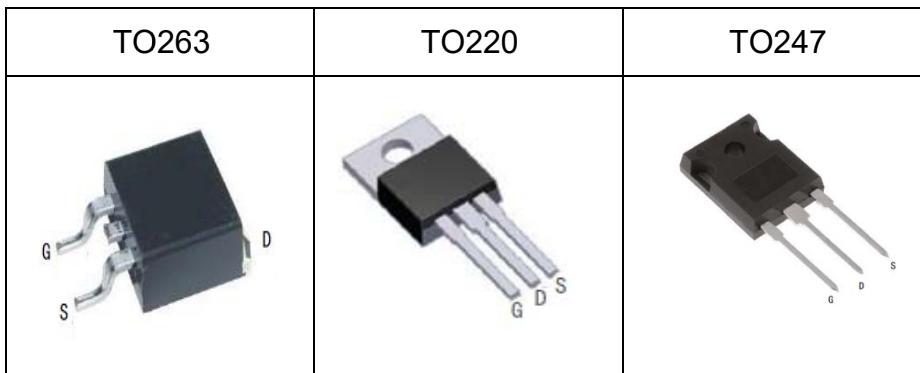
Low drain-source on-resistance:  $R_{DS(ON)} = 2.9\text{m}\Omega$  (typ.)  
High speed power switching  
Enhanced body diode dv/dt capability  
Enhanced avalanche ruggedness

**Table 1 Key Performance Parameters**

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	85	V
$R_{DS(on),max}$	3.3	$\text{m}\Omega$
$Q_{g,typ}$	109	nC
$I_{D,pulse}$	640	A

**3. Packaging and Internal Circuit**

Part Name	Package	Marking
AUB033N08BG	TO263	AUB033N08BG
AUP033N08BG	TO220	AUP033N08BG
AUW033N08BG	TO247	AUW033N08BG



## 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$		-	160 115	A	$T_C=25^\circ\text{C}$ $T_C=100^\circ\text{C}$
Pulsed drain current <sup>2)</sup>	$I_{D,\text{pulse}}$	-		640	A	$T_C=25^\circ\text{C}$
Avalanche energy, single pulse	$E_{AS}$	-	-	884	mJ	
Gate source voltage (static)	$V_{GS}$	-20	-	20	V	static;
Power dissipation(TO220)	$P_{\text{tot}}$	-	-	370	W	$T_C=25^\circ\text{C}$
Power dissipation(TO263)	$P_{\text{tot}}$	-	-	179	W	$T_C=25^\circ\text{C}$
Power dissipation(TO247)	$P_{\text{tot}}$	-	-	340	W	$T_C=25^\circ\text{C}$
Storage temperature	$T_{\text{stg}}$	-55	-	175	°C	
Operating junction temperature	$T_j$	-55	-	175	°C	

<sup>1)</sup>Limited by  $T_{j,\text{max}}$ . Maximum Duty Cycle D = 0.50

<sup>2)</sup>Pulse width  $t_p$  limited by  $T_{j,\text{max}}$

<sup>3)</sup>Identical low side and high side switch with identical  $R_G$

## 2 Thermal characteristics

**Table 3 Thermal characteristics(TO220)**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.42	°C/W	-
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	62	°C/W	device on PCB, minimal footprint

**Thermal characteristics (TO263)**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.7	°C/W	-
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	62	°C/W	device on PCB, minimal footprint

**Thermal characteristics (TO247)**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.44	°C/W	-
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	40	°C/W	device on PCB, minimal footprint

### 3 Electrical characteristics

at  $T_j=25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	85	-	-	V	$V_{GS}=0\text{V}, I_D=10\text{mA}$
Gate threshold voltage	$V_{(\text{GS})\text{th}}$	2.5		3.5	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$
Zero gate voltage drain current	$I_{\text{DSS}}$	-	-	1000	nA	$V_{DS}=80\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$
Gate-source leakage current	$I_{\text{GSS}}$	-	-	100	nA	$V_{GS}=20\text{V}, V_{DS}=0\text{V}$
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}$	-	2.9	3.3	$\text{m}\Omega$	$V_{GS}=10\text{V}, I_D=20\text{A}, T_j=25^\circ\text{C}$
Gate resistance (Intrinsic)	$R_G$	-	0.7	-	$\Omega$	f=1MHz, open drain

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{\text{iss}}$	-	7463	-	pF	$V_{DS}=40\text{V}, V_{GS}=0\text{V}$ f=1MHz
Output capacitance	$C_{\text{oss}}$	-	1292	-	pF	$V_{DS}=40\text{V}, V_{GS}=0\text{V}$ f=1MHz
Reverse transfer capacitance	$C_{\text{rss}}$	-	43.4	-	pF	$V_{DS}=40\text{V}, V_{GS}=0\text{V}$ f=1MHz
Turn-on delay time	$t_{d(\text{on})}$	-	24	-	ns	$V_{DD}=40\text{V}, V_{GS}=10\text{V}, RG=10\Omega$ $ID=20\text{A}$
Rise time	$t_r$	-	53	-	ns	$V_{DD}=40\text{V}, V_{GS}=10\text{V}, RG=10\Omega$ $ID=20\text{A}$
Turn-off delay time	$t_{d(\text{off})}$	-	107	-	ns	$V_{DD}=40\text{V}, V_{GS}=10\text{V}, RG=10\Omega$ $ID=20\text{A}$
Fall time	$t_f$	-	66	-	ns	$V_{DD}=40\text{V}, V_{GS}=10\text{V}, RG=10\Omega$ $ID=20\text{A}$

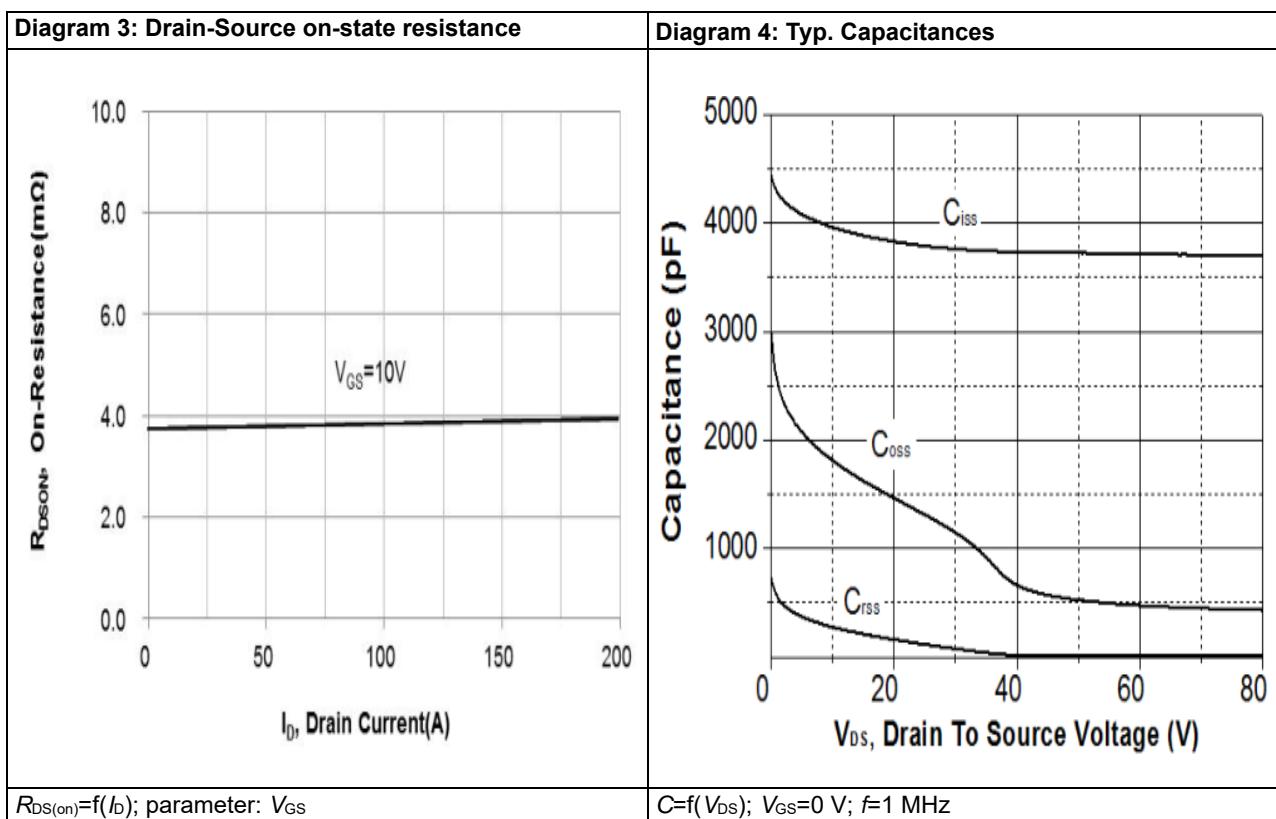
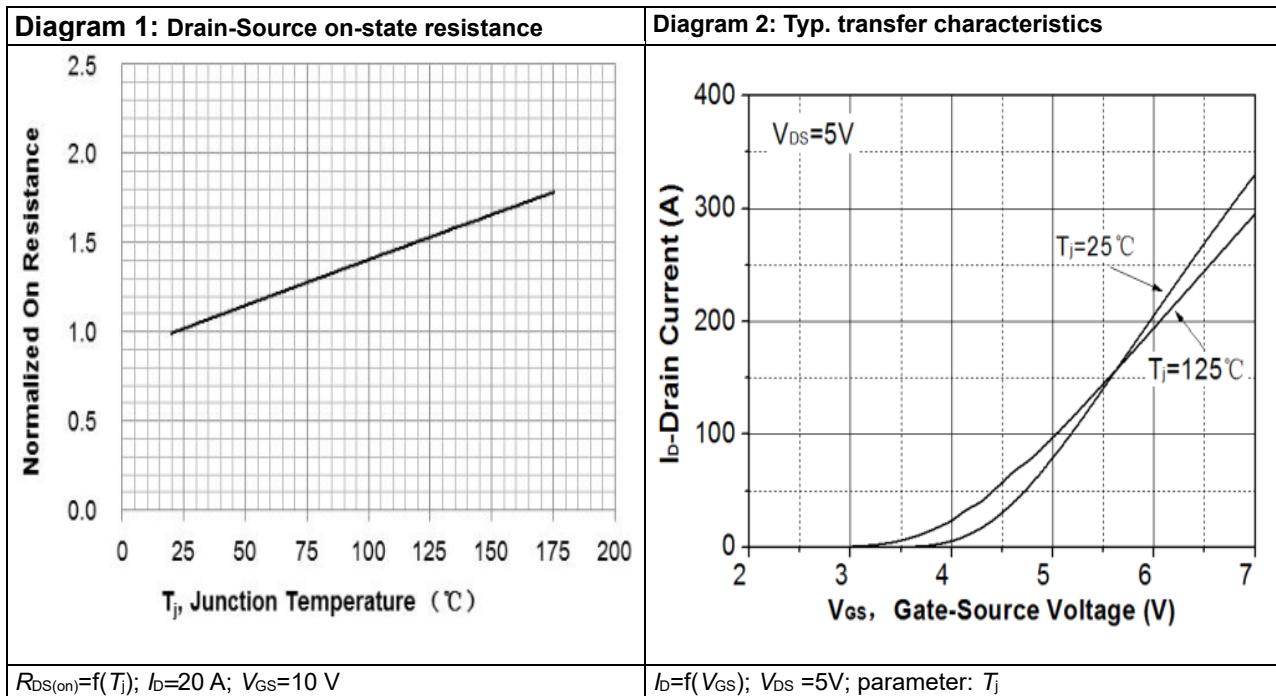
**Table 6 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{\text{gs}}$	-	27.5	-	nC	$V_{DS}=40\text{V}, V_{GS}=0 \text{ to } 10\text{V}$ $ID=20\text{A}$
Gate to drain charge	$Q_{\text{gd}}$	-	26.4	-	nC	$V_{DS}=40\text{V}, V_{GS}=0 \text{ to } 10\text{V}$ $ID=20\text{A}$
Gate charge total	$Q_g$	-	109	-	nC	$V_{DS}=40\text{V}, V_{GS}=0 \text{ to } 10\text{V}$ $ID=20\text{A}$

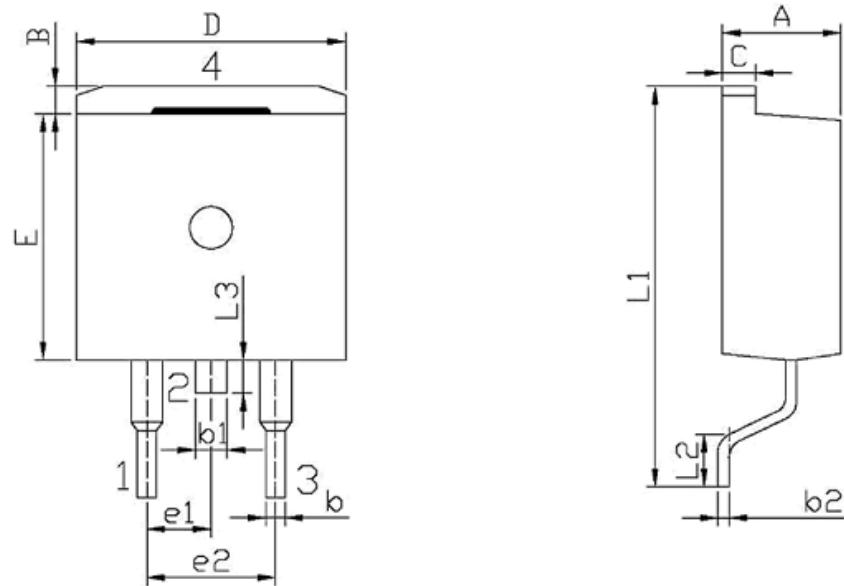
**Table 7 Reverse diode characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	$V_{SD}$	-	0.67	-	V	$V_{GS}=0V, I_F=1A, T_j=25^\circ C$
Reverse recovery time	$t_{rr}$	-	52	-	ns	$VR=40V, IF=20A, dI/dt=200A/us$
Reverse recovery charge	$Q_{rr}$	-	137	-	uC	$VR=40V, IF=20A, dI/dt=200A/us$
Peak reverse recovery current	$I_{rrm}$	-	-3.7	-	A	$VR=40V, IF=20A, dI/dt=200A/us$

## Electrical characteristics diagram



## 4 Package Outlines



单位: mm

Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters	
	Min	Max		Min	Max
A	4.30	4.70	E	9.00	9.40
B	1.00	1.40	e1	2.34	2.74
b	0.70	0.90	e2	4.88	5.28
b1	1.15	1.35	L1	15.00	16.00
b2	0.40	0.60	L2	2.24	2.84
C	1.20	1.40	L3	1.20	1.60
D	9.80	10.20			

Figure1: Outline PG-T0263

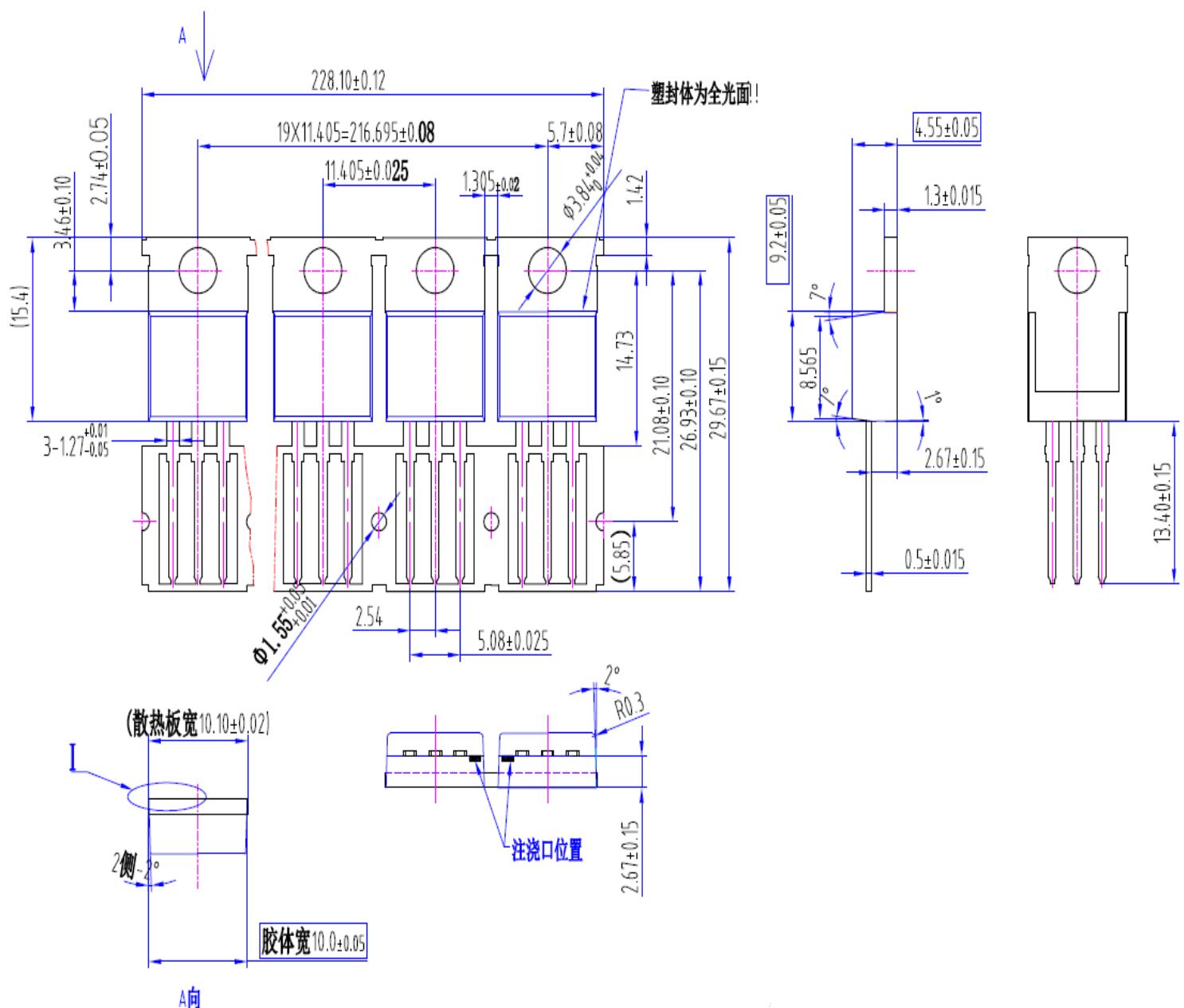


Figure2: Outline PG-T0220

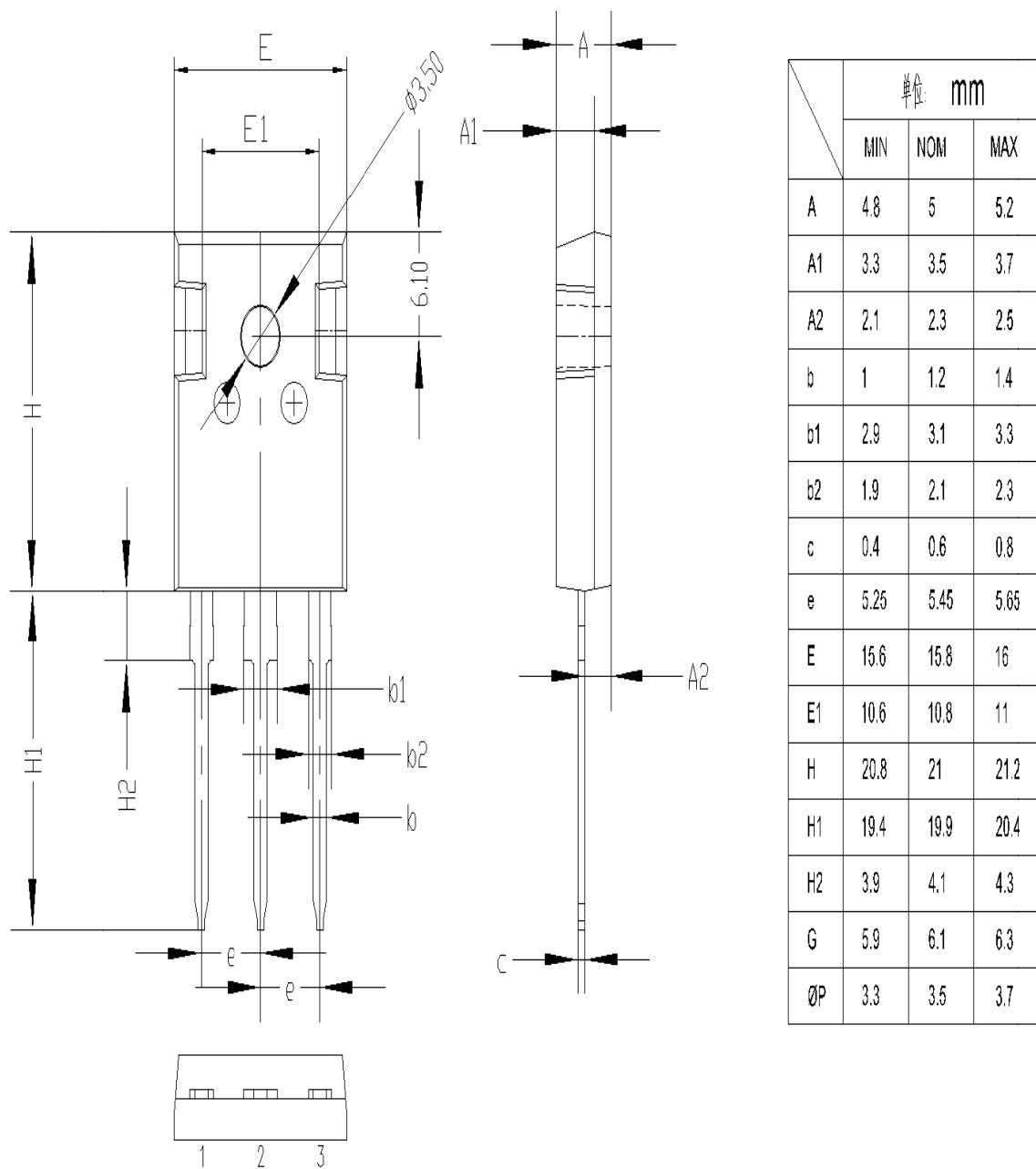


Figure3: Outline PG-T0247

**Revision History**

Revision	Date	Subjects (major changes since last revision)
1.0	2021-06-1	Preliminary version